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Application/Control No.	Applicant(s)/Patent under Reexamination
10/674,352	LIN ET AL.
Examiner	Art Unit
DON N. VO	2611

SEARCHED				
Class	Subclass	Date	Examiner	
375	233, 340, 345, 350	11/30/2006	DV	
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INI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
375	340, 350	11/30/2006	DV	
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SEARCH NO (INCLUDING SEARCH		)
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INVENTOR NAME SEARCHED	11/28/2006	DV
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